VLSI Devices Lecture 17

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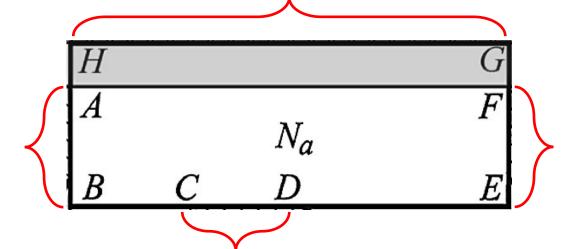
Coverage

- Two YouTube lectures reserved for advanced topics
 - -L14: Substrate bias, channel mobility
 - -L15: 3.2.1
 - -L16: 3.2.1 (Continued)
 - -L17: Velocity saturation (3.2.2)
 - -L18: Channel length modulation and so on (3.2.3, 3.2.4, 3.2.5)
 - -L19: MOSFET scaling
 - L20: MOSFET scaling (Continued)
 - -L21: Quantum effect (4.2.4)
 - L22: Double-gate MOSFETs (10.3)
 - -L23: FinFETs
 - -L24: CFETs

Boundary conditions

- Potential reference is $\phi(\infty, y) = -\phi_B$.
 - -Along GH: $\phi = V_{gs} V_{fb}$ Taur, Eq. (A9.3)
 - -Along AB: $\phi = \phi_{bi} \approx \frac{E_g}{2q} + \phi_B$ Taur, Eq. (A9.4)
 - -Along EF: $\phi = \phi_{bi} + V_{ds}$ Taur, Eq. (A9.5)
 - -Along CD: $\phi = 0$ Taur, Eq. (A9.6)

 $-(3t_{ox})$ for uniform permittivity)



Solution

- Poisson equation with boundary conditions
 - Try the following function for the electrostatic potential:

$$\phi(x,y) = v(x,y) + u_L(x,y) + u_R(x,y) + u_B(x,y)$$
 Taur, Eq. (A9.9)

Poisson equation with upper b.c. (Long-channel)

Laplace equation to match left b.c.

Laplace equation to match right b.c.

to match bottom b.c.

Solution, v(x, y)

- Actually, it is v(x).
 - -For the oxide region ($-3t_{ox} \le x \le 0$), $v(x,y) = \phi_s \frac{V_{gs} V_{fb} \phi_s}{3t_{ox}}x$
 - For the silicon region ($0 \le x \le W_d$),

$$v(x,y) = \phi_S \left(1 - \frac{x}{W_d} \right)^2$$

- It is noted that

$$\phi_s = \frac{qN_aW_d^2}{2\epsilon_{si}}$$

Taur, Eq. (A9.10)

Taur, Eq. (A9.11)

Taur, Eq. (A9.12)

A mode for $u_R(x, y)$

- For three boundaries, it should vanish.
 - At only one side, it has non-zero values.
 - We can try ($\lambda \equiv W_d + 3t_{ox}$)

$$u_{R,n}(x,y) = \sinh\left(\frac{n\pi y}{\lambda}\right) \sin\left(\frac{n\pi(x+3_{tox})}{\lambda}\right)$$

$$u_{R} = 0$$

$$u_{R} = 0$$

$$u_{R} = 0$$

$$A$$

$$B$$

$$C$$

$$D$$

$$E$$

$$u_{R} = \phi(x, L) - v(x, L)$$

$$u_R = 0$$

Series expansion of $u_R(x,y)$

- $u_R(x,L) = \phi(x,L) v(x,L)$ can be expanded with coefficients
 - -Therefore,

$$u_R(x,y) = \sum_{n=1}^{\infty} c_n \frac{\sinh\left(\frac{n\pi y}{\lambda}\right)}{\sinh\left(\frac{n\pi L}{\lambda}\right)} \sin\left(\frac{n\pi(x+3_{tox})}{\lambda}\right)$$
 Taur, Eq. (A9.15)

• Similar solutions are found for $u_L(x,y)$ and $u_B(x,y)$.

ilar solutions are found for
$$u_L(x,y)$$
 and $u_B(x,y)$.
$$u_L(x,y) = \sum_{n=1}^{\infty} b_n \frac{\sinh\left(\frac{n\pi(L-y)}{\lambda}\right)}{\sinh\left(\frac{n\pi L}{\lambda}\right)} \sin\left(\frac{n\pi(x+3_{tox})}{\lambda}\right)$$
Taur, Eq. (A9.14)

First-order expansion

- Keep only b_1 and c_1 . (u_B is neglected.)
 - -Then, $\begin{aligned} & \phi(x,y) \\ &= \phi_s \left(1 - \frac{x}{W_d} \right)^2 \\ &+ \frac{b_1 \sinh\left(\frac{\pi(L-y)}{\lambda}\right) + c_1 \sinh\left(\frac{\pi y}{\lambda}\right)}{\sinh\left(\frac{\pi L}{\lambda}\right)} \sin\left(\frac{\pi(x+3_{tox})}{\lambda}\right) \\ &+ \frac{\sinh\left(\frac{\pi L}{\lambda}\right)}{\sinh\left(\frac{\pi L}{\lambda}\right)} \text{ and } c_1 \text{ are } \frac{4}{\pi}(\phi_{bi} - a\phi_s) \text{ and} \end{aligned}$ $\phi(x,y)$ Taur, Eq. (A9.22)
 - –Approximate values for b_1 and c_1 are $\frac{4}{\pi}(\phi_{bi}-a\phi_s)$ and $\frac{4}{\pi}(\phi_{bi}+$ $V_{ds} - a\phi_s$), respectively. $a \approx 0.4$.

Surface potential

• At x = 0,

$$\phi(0,y) = \phi_S + \frac{b_1 \sinh\left(\frac{\pi(L-y)}{\lambda}\right) + c_1 \sinh\left(\frac{\pi y}{\lambda}\right)}{\sinh\left(\frac{\pi L}{\lambda}\right)} \sin\left(\frac{\pi 3t_{ox}}{\lambda}\right)$$
Taur, Eq. (A9.22)

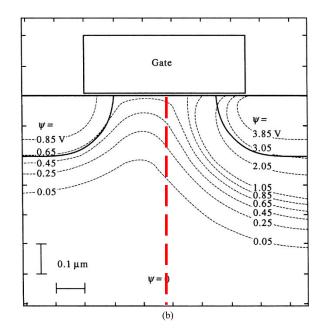
-Let's find the minimum potential.

$$\frac{d}{dy}\phi(0,y) = \frac{\pi}{\lambda} \frac{-b_1 \cosh\left(\frac{\pi(L-y)}{\lambda}\right) + c_1 \cosh\left(\frac{\pi y}{\lambda}\right)}{\sinh\left(\frac{\pi L}{\lambda}\right)} \sin\left(\frac{\pi 3t_{ox}}{\lambda}\right) = 0$$

$$b_1 \cosh\left(\frac{\pi(L-y)}{\lambda}\right) = c_1 \cosh\left(\frac{\pi y}{\lambda}\right)$$

Position for minimum potential, $y = y_c$

• For a positive
$$z$$
, $\cosh z \approx \frac{\exp z}{2}$.
$$\exp \frac{\pi (L^2 - 2y_c)}{\lambda} = \frac{c_1}{b_1}$$
$$y_c = \frac{L}{2} - \frac{\lambda}{2\pi} \ln \frac{c_1}{b_1} \approx \frac{L}{2} - \frac{W_d + 3t_{ox}}{2\pi} \ln \left(1 + \frac{V_{ds}}{\phi_{bi} - a\phi_s}\right)$$



Taur, Eq. (A9.23)

Potential profile (Taur, Fig. 3.20(b))

Minimum potential at $y = y_c$

Using some approximations,

$$\phi(0, y_c) = \phi_s + 2\sqrt{b_1 c_1} \exp\left(-\frac{\pi L}{2\lambda}\right) \sin\left(\frac{\pi 3 t_{ox}}{\lambda}\right)$$

$$\approx \phi_s$$

$$\approx \phi_{s} + \left(\frac{6\pi t_{ox}}{\lambda}\right) \left(\sqrt{\phi_{bi}(\phi_{bi} + V_{ds})} - \frac{2\phi_{bi} + V_{ds}}{2\sqrt{\phi_{bi}(\phi_{bi} + V_{ds})}} a\phi_{s}\right) \exp\left(-\frac{\pi L}{2\lambda}\right)$$

~ Taur, Eq. (A9.24)

-Threshold voltage lowering, ΔV_t ,

$$= \left(\frac{24t_{ox}}{W_{dm}}\right) \left(\sqrt{\phi_{bi}(\phi_{bi} + V_{ds})} - a(2\phi_B)\right) \exp\left(-\frac{\pi L}{2(W_{dm} + 3t_{ox})}\right)$$

Taur, Eq. (A9.25)

Typical values in the textbook

Following Taur, Eq. (3.67),

$$= \left(\frac{24t_{ox}}{W_{dm}}\right) \left(\sqrt{\phi_{bi}(\phi_{bi} + V_{ds})} - a(2\phi_B)\right) \exp\left(-\frac{\pi L}{2(W_{dm} + 3t_{ox})}\right)$$

Using typical values,

$$0.1 = (2.4)(\sqrt{2} - 0.4) \exp\left(-\frac{\pi L}{2(1.3W_{dm})}\right)$$

- -We get $L \approx 2.6W_{dm} \approx 2(W_{dm} + 3t_{ox})$.
- -The minimum allowable channel length is $L_{min} \approx 2(W_{dm} + 3t_{ox})$.

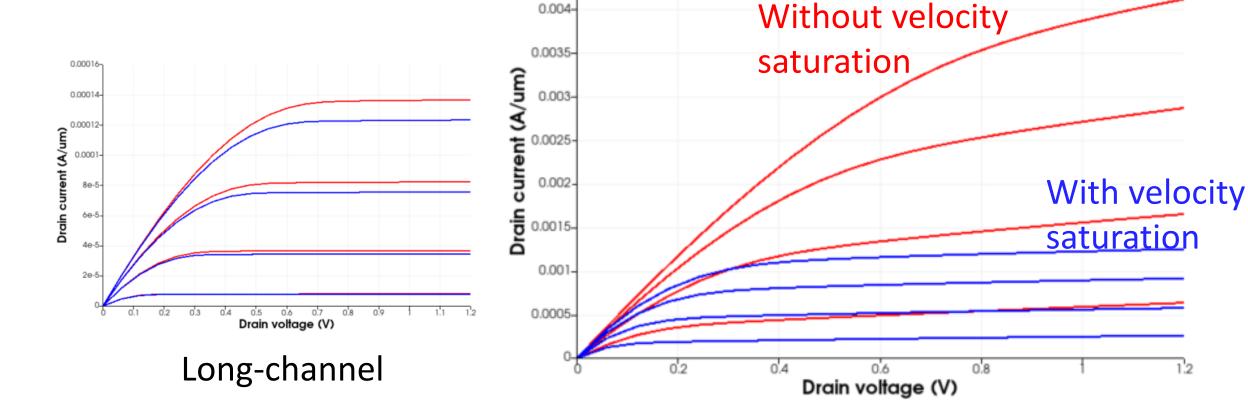
Velocity saturation

Impact of velocity saturation

-Saturation occurs at a much lower voltage (than $V_{dsat} =$

0.0045

 $(V_{gs}-V_t)/m$).

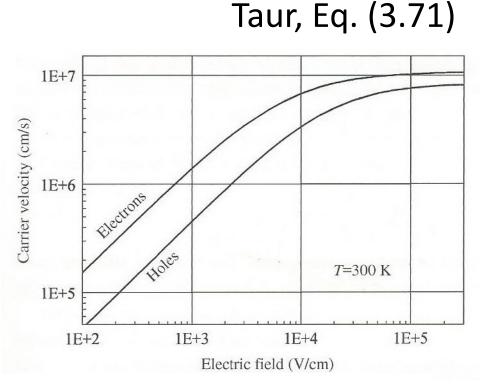


Velocity-field relationship

- Caughey-Thomas
 - -Saturation may occur at a much lower voltage (than $V_{dsat} = \frac{V_{gs} V_t}{m}$).

$$v = \frac{\mu_{eff} \mathcal{E}}{[1 + (\mathcal{E}/\mathcal{E}_c)^n]^{1/n}}$$

- Critical field, \mathcal{E}_c
- For electrons, n=2. For holes, n=1
- –At low fields, $v=\mu_{eff}\mathcal{E}$
- -At high fields ($\mathcal{E} \to \infty$), $v \to \mu_{eff} \mathcal{E}_c = v_{sat}$



Velocity-field relationship (Taur, Fig. 2.10)

Analytic solution for n = 1 (1)

Valid for holes (PMOSFET)

$$I_{d} = -WQ_{i}(V) \frac{\mu_{eff} \frac{dV}{dy}}{1 + \left(\frac{\mu_{eff}}{v_{sat}}\right) \frac{dV}{dy}}$$

Taur, Eq. (3.73)

- Rearranging

$$I_d \left[1 + \left(\frac{\mu_{eff}}{v_{sat}} \right) \frac{dV}{dy} \right] = -W Q_i(V) \mu_{eff} \frac{dV}{dy}$$

$$I_{d} = -\left[\mu_{eff}WQ_{i}(V) + \left(\frac{\mu_{eff}I_{d}}{v_{sat}}\right)\right]\frac{dV}{dy}$$

Taur, Eq. (3.74)

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Analytic solution for n=1 (2)

Drain current with velocity saturation

$$I_{d}dy = -\left[\mu_{eff}WQ_{i}(V) + \left(\frac{\mu_{eff}I_{d}}{v_{sat}}\right)\right]dV$$

-Integration from y = 0 to L (from V = 0 to V_{ds})

$$I_{d}L = -\mu_{eff}W \int_{0}^{V_{ds}} Q_{i}(V)dV - \left(\frac{\mu_{eff}I_{d}}{v_{sat}}\right)V_{ds}$$

$$I_{d}L \left(1 + \frac{\mu_{eff}V_{ds}}{v_{sat}L}\right) = -\mu_{eff}W \int_{0}^{V_{ds}} Q_{i}(V)dV$$

$$I_{d} = \frac{-\mu_{eff}(W/L) \int_{0}^{V_{ds}} Q_{i}(V)dV}{1 + \left(\mu_{eff}V_{ds}/v_{sat}L\right)}$$

Taur, Eq. (3.75)

Analytic solution for n=1 (3)

Using the chage-sheet model

$$Q_i = -C_{ox}(V_{gs} - V_t - mV)$$

Taur, Eq. (3.76)

$$I_{d} = \frac{\mu_{eff} C_{ox}(W/L) \left[(V_{gs} - V_{t}) V_{ds} - \frac{m}{2} V_{ds}^{2} \right]}{1 + (\mu_{eff} V_{ds} / v_{sat} L)}$$

Taur, Eq. (3.77)

– By solving
$$\frac{dI_d}{dV_{ds}}=0$$
 at V_{dsat}

- By solving
$$\frac{dI_d}{dV_{ds}} = 0$$
 at V_{dsat} ,
$$0 = \frac{(V_{gs} - V_t) - mV_{dsat}}{1 + (\mu_{eff}V_{dsat}/v_{sat}L)} - \frac{(V_{gs} - V_t)V_{dsat} - \frac{m}{2}V_{dsat}^2}{[1 + (\mu_{eff}V_{dsat}/v_{sat}L)]^2} (\mu_{eff}/v_{sat}L)$$

Analytic solution for n=1 (4)

Manipulation

$$\begin{split} & [(V_{gs} - V_t) - mV_{dsat}][1 + (\mu_{eff}V_{dsat}/v_{sat}L)] \\ & = \left[(V_{gs} - V_t)V_{dsat} - \frac{m}{2}V_{dsat}^2\right](\mu_{eff}/v_{sat}L) \\ & V_{dsat} = \frac{2(V_{gs} - V_t)/m}{1 + \sqrt{1 + 2\mu_{eff}(V_{gs} - V_t)/(mv_{sat}L)}} \leq (V_{gs} - V_t)/m \\ & -L \to \infty, V_{dsat} = (V_{gs} - V_t)/m \\ & -L \to 0, \end{split}$$
 Taur, Eq. (3.78)

$$V_{dsat} = \sqrt{\frac{2(V_{gs} - V_t)v_{sat}L}{\mu_{eff}m}}$$

Analytic solution for n = 1 (5)

Two extreme cases

$$-L \rightarrow \infty$$
,

$$I_{dsat} = \mu_{eff} C_{ox} \frac{W (V_{gs} - V_t)^2}{L 2m}$$
 Taur, Eq. (3.80)

 $-L \rightarrow 0$,

$$I_{dsat} = C_{ox}Wv_{sat}(V_{gs} - V_t)$$
 Taur, Eq. (3.81)

-In this case, I_{dsat} is independent of channel length L and varies linearly with $V_{gs}-V_t$ instead of quadratically as in the long-channel case.

Thank you!